

# HCS55R140E

## 550V N-Channel Super Junction MOSFET

### Features

- Very Low FOM ( $R_{DS(on)} \times Q_g$ )
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested

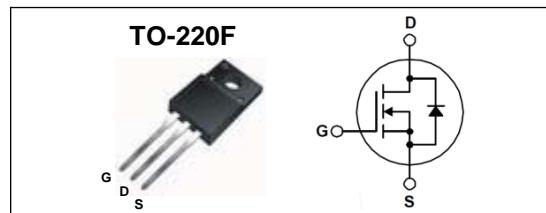
### Key Parameters

Parameter	Value	Unit
$BV_{DSS} @ T_{j,max}$	600	V
$I_D$	23	A
$R_{DS(on), max}$	0.14	$\Omega$
$Q_{g, Typ}$	22	nC

### Application

- Lighting
- Hard Switching PWM
- Server Power Supply
- Charger

### Package & Internal Circuit



### Absolute Maximum Ratings

$T_C=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	550	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Drain Current – Continuous ( $T_C = 25^\circ\text{C}$ )	23.0 *	A
	Drain Current – Continuous ( $T_C = 100^\circ\text{C}$ )	14.5 *	A
$I_{DM}$	Drain Current – Pulsed (Note 1)	69.0 *	A
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	610	mJ
$dv/dt$	MOSFET $dv/dt$ ruggedness, $V_{DS}=0\ldots 400\text{V}$	50	V/ns
$dv/dt$	Reverse diode $dv/dt$ , $V_{DS}=0\ldots 400\text{V}$ , $I_{DS} \leq I_D$	15	V/ns
$P_D$	Power Dissipation	34	W
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature

### Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	3.67	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

## Electrical Characteristics $T_J=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### On Characteristics

$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.0	--	4.0	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 11.5 \text{ A}$	--	0.11	0.14	$\Omega$

### Off Characteristics

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	550	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 550 \text{ V}$ , $V_{GS} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{DS} = 440 \text{ V}$ , $T_J = 125^\circ\text{C}$	--	--	100	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 30 \text{ V}$ , $V_{DS} = 0 \text{ V}$	--	--	$\pm 100$	nA

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 50 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$	--	1410	--	pF
$C_{oss}$	Output Capacitance		--	150	--	pF
$C_{rss}$	Reverse Transfer Capacitance		--	4.1	--	pF

### Switching Characteristics

$t_{d(on)}$	Turn-On Time	$V_{DS} = 420 \text{ V}$ , $I_D = 23 \text{ A}$ , $R_G = 25 \Omega$	--	48	--	ns
$t_r$	Turn-On Rise Time		--	22	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	78	--	ns
$t_f$	Turn-Off Fall Time		--	21	--	ns
$Q_g$	Total Gate Charge	$V_{DS} = 420 \text{ V}$ , $I_D = 23 \text{ A}$ $V_{GS} = 10 \text{ V}$	--	22	29	nC
$Q_{gs}$	Gate-Source Charge		--	9	--	nC
$Q_{gd}$	Gate-Drain Charge		--	4.5	--	nC

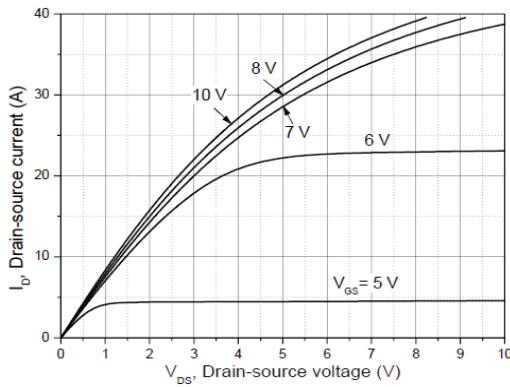
### Source-Drain Diode Maximum Ratings and Characteristics

$I_S$	Continuous Source-Drain Diode Forward Current	--	--	23	A	
$I_{SM}$	Pulsed Source-Drain Diode Forward Current	--	--	69		
$V_{SD}$	Source-Drain Diode Forward Voltage	$I_S = 23 \text{ A}$ , $V_{GS} = 0 \text{ V}$	--	--	1.4	V
$trr$	Reverse Recovery Time	$I_S = 23 \text{ A}$ , $V_{GS} = 0 \text{ V}$ $di_F/dt = 100 \text{ A}/\mu\text{s}$	--	372	--	ns
$Qrr$	Reverse Recovery Charge		--	5.1	--	$\mu\text{C}$

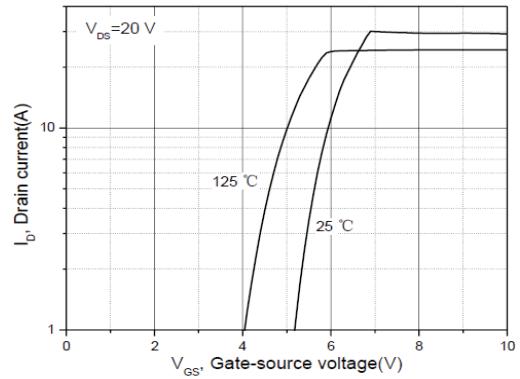
#### Notes :

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=6\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$

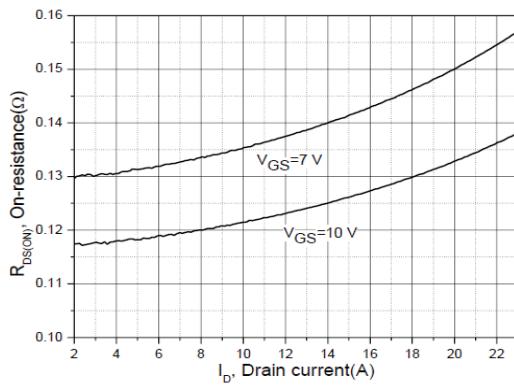
## Typical Characteristics



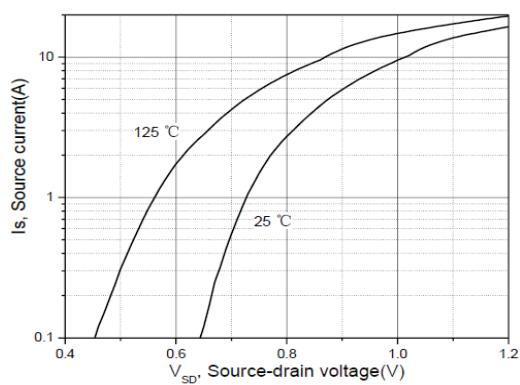
**Figure 1. On Region Characteristics**



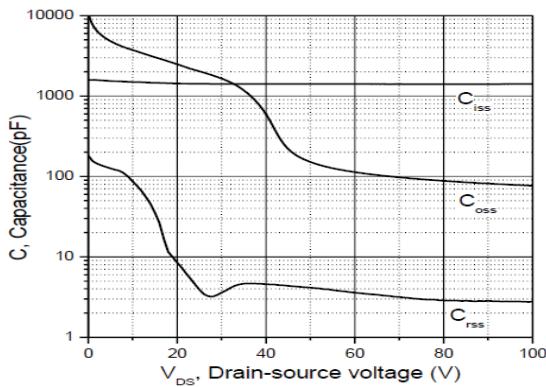
**Figure 2. Transfer Characteristics**



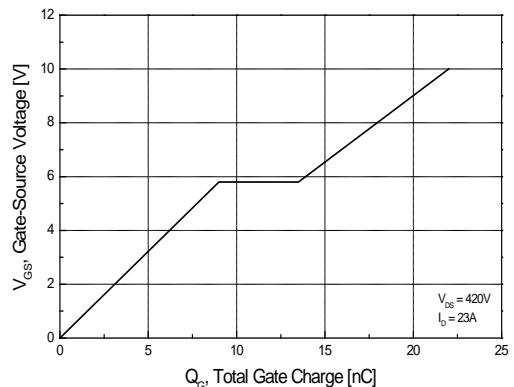
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

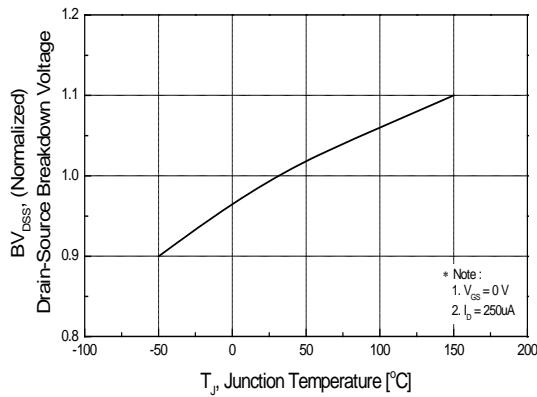


**Figure 5. Capacitance Characteristics**

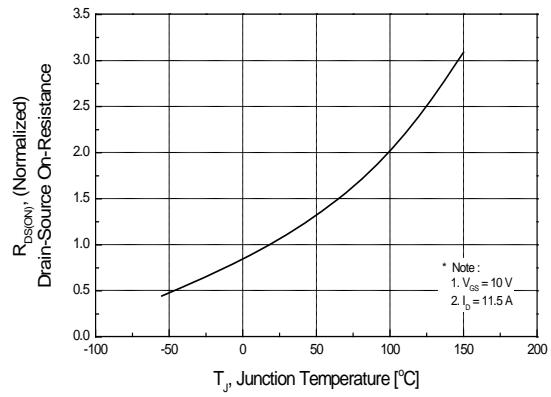


**Figure 6. Gate Charge Characteristics**

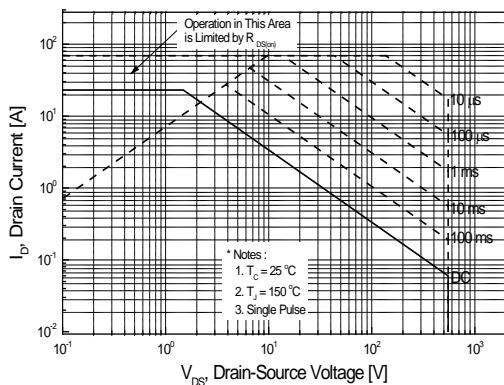
## Typical Characteristics (continued)



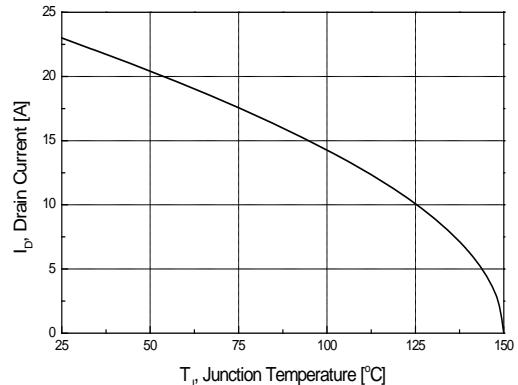
**Figure 7. Breakdown Voltage Variation vs Temperature**



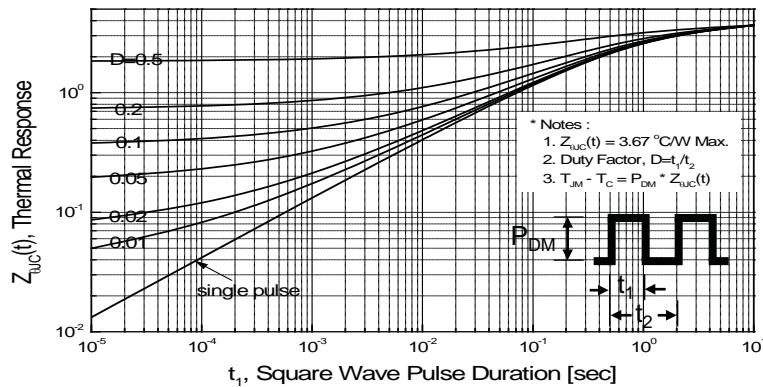
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs Case Temperature**



**Figure 11. Transient Thermal Response Curve**

Fig 12. Gate Charge Test Circuit & Waveform

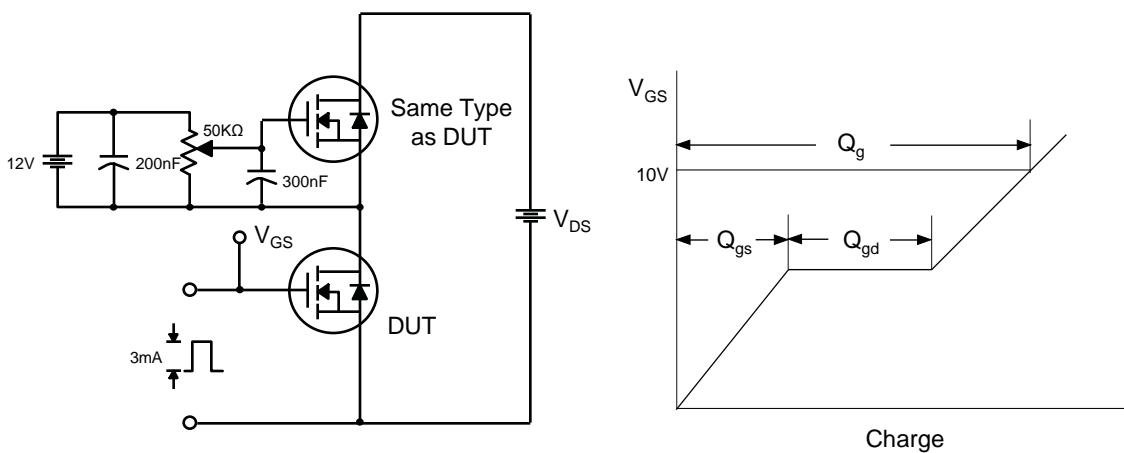


Fig 13. Resistive Switching Test Circuit & Waveforms

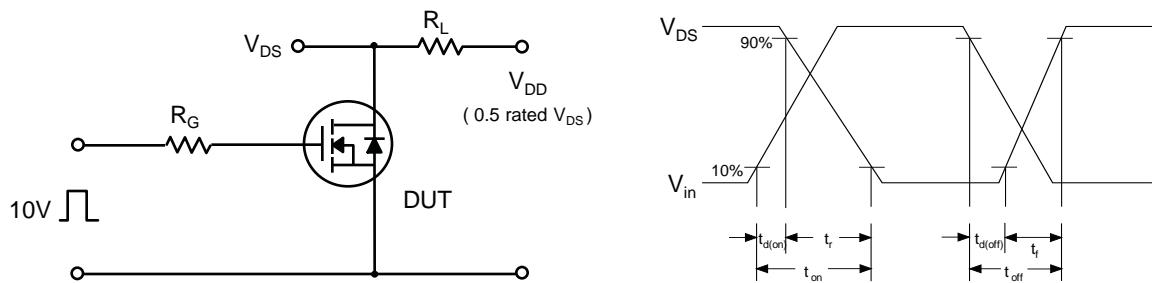


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

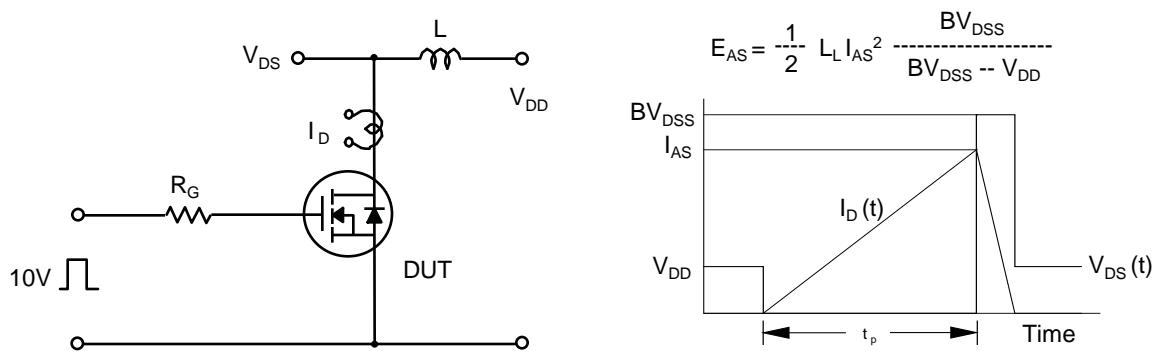
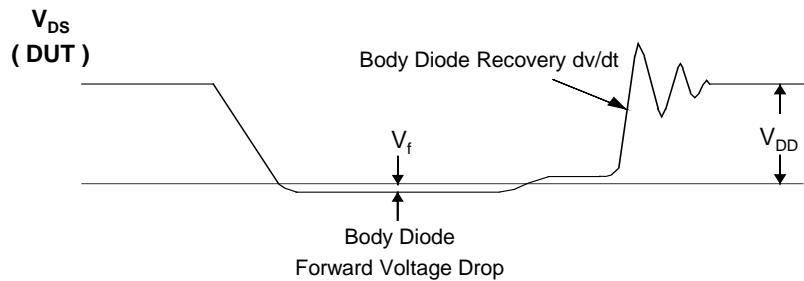
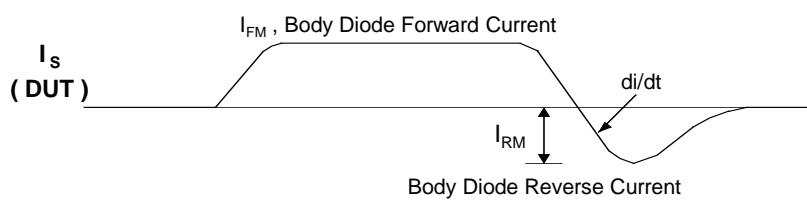
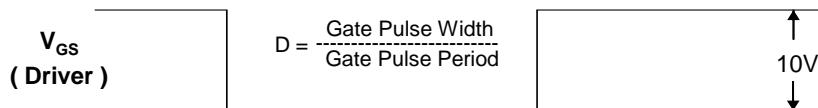
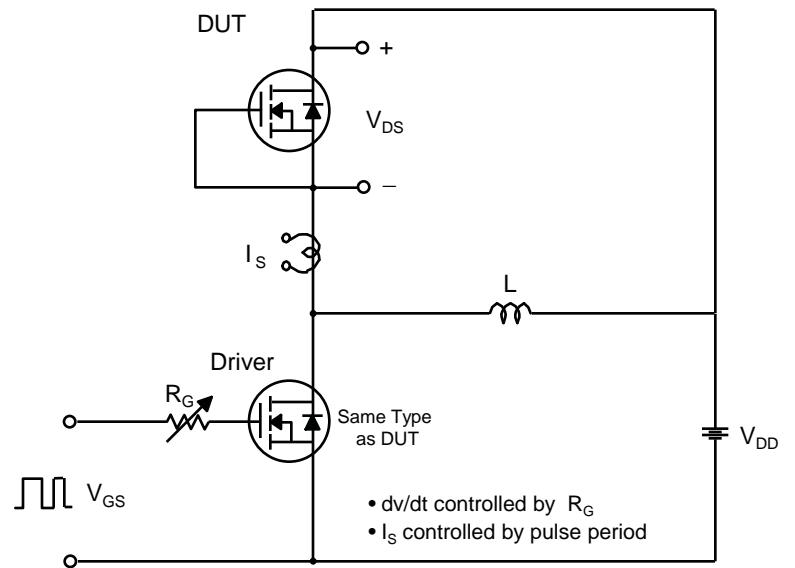


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



## Package Dimension

TO-220F

